Search Notes



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Reexamination

Applicant(s)/Patent Under

YOON ET AL.

Examiner

VENKATESH HALIYUR

Art Unit

2619

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------|------------|----------|
| 370 | 252,392,401 | 06/28/2008 | VH |
| 709 | 224 | 06/28/2008 | VH |

SEARCH NOTES

| Search Notes | Date | Examiner |
|--------------------------------------|------------|----------|
| EAST(updated text search) | 06/27/2008 | VH |
| EAST(updated class/subclass search) | 06/27/2008 | VH |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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